Fano and Kondo Resonance in Electronic Current through Nanodevices

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Electronic transport through a quantum dot strongly coupled to electrodes is studied within a model with two conduction channels. It is shown that multiple scattering and interference of transmitted waves through both channels lead to Fano resonance associated with Kondo resonance. Interference effects are also pronouncedly seen in transport through the Aharonov-Bohm ring with the Kondo dot, where the current characteristics continuously evolve with the magnetic flux.

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Recent electron transport experiments performed in a single electron transistor strongly coupled to electrodes [1] and by a scanning tunneling microscope (STM) on a single magnetic adatom on a metallic surface [2,3] showed that the Kondo resonance [4] occurs simultaneously with the Fano resonance [5]. Multiple scatterings of traveling electronic waves on a localized magnetic state are crucial for a formation of both resonances. The condition for the Fano resonance to appear is the presence of at least two scattering channels: the discrete level and the broad continuum band [5,6]. In the mesoscopic systems the nature of two conduction channels is dependent on the geometry of the device under consideration. Interferometer geometry is realized when an Aharonov-Bohm ring with a quantum dot (QD) placed in one of the arms is studied [7-9]. When an adatom is deposited on the metallic surface, the STM tip probes indirectly the hybridized local adatom level together with the band of surface electrons [2,3,10,11]. We consider the transmission geometry, when the coupling of the QD to the leads increases to a strong regime [1] and additional transmission channels are activated. The QD is a multilevel system and the transmission through a higher level (close to the Fermi energy) can be treated as an effective bridge channel. Although the electron transport through the QD is governed by the Kondo effect, interference processes are essential and can produce the Fano-shaped resonances. It is also interesting to analyze the Aharonov-Bohm ring with the Kondo impurity. In such a system one can continuously change the interference conditions by varying a magnetic flux and can observe the resulting evolution of the current characteristics from the Kondo peak to the Fano dip. The studies have been performed for various energies of the impurity state: in the Kondo regime, in the mixed-valence regime, as well as in the empty state regime.

Our model is described by the Hamiltonian

$$H = \sum_{k,\sigma,\alpha\in L,R} \epsilon_{k\alpha} c^{\dagger}_{k\alpha,\sigma} c_{k\alpha,\sigma} + \sum_{\sigma} \left[\epsilon_0 c^{\dagger}_{0\sigma} c_{0\sigma} + \frac{U}{2} c^{\dagger}_{0\sigma} c_{0\sigma} c^{\dagger}_{0-\sigma} c_{0-\sigma} \right] + \sum_{k,\sigma} \left[t_{L0} c^{\dagger}_{kL,\sigma} c_{0\sigma} + t_{R0} c^{\dagger}_{kR,\sigma} c_{0\sigma} + \text{H.c.} \right] + \sum_{k,k',\sigma} \left[t_{LR} c^{\dagger}_{kL,\sigma} c_{k'R,\sigma} + \text{H.c.} \right].$$
(1)

The first term describes electrons in the left (L) and the right (R) electrodes, the second one describes the quantum dot with a single state ϵ_0 and Coulomb interactions characterized by the parameter U, the third one corresponds to the tunneling from the electrodes to the dot, and the last one describes the *bridge* channel over the dot.

The current from the left electrode can be calculated from the time evolution of the occupation number $N_L = \sum_{k,\sigma} c_{kL,\sigma}^{\dagger} c_{kL,\sigma}$ for electrons in the left electrode using the Green functions of the Keldysh type [12]. The result is

$$J = \frac{2e}{\hbar} \int \frac{d\omega}{2\pi} \operatorname{Re} \left[\sum_{k,\sigma} t_{L0} G_{0,kL\sigma}^{<}(\omega) + \sum_{k,k',\sigma} t_{LR} G_{k'R\sigma,kL\sigma}^{<}(\omega) \right], \quad (2)$$

where $G_{0,kL\sigma}^{<}(\omega)$ and $G_{k'R\sigma,kL\sigma}^{<}(\omega)$ are the lesser Green functions corresponding to the states at the dot and in the left electrode or the states in both the electrodes, respec-

tively. Next, we use the Dyson equation to calculate the nonequilibrium Green functions and express J only by the Green function G_{00} at the dot and the bare Green functions g_{α} in the electrodes. The lesser, retarded, and advanced Green functions g_{α} are taken in the form $g_{\alpha}^{<} = 2i\pi\rho f_{\alpha}$ and $g_{\alpha}^{r,a} = \mp i\pi\rho$, where f_{α} denotes the Fermi distribution function for electrons in the α electrode and ρ is the density of states. All multiple scatterings on the dot and the contacts, as well as interference processes, are taken into account. Assuming quasielastic transport, for which the current conservation rule is fulfilled for any energy ω , one obtains

$$J = \frac{2e}{h} \int d\omega [f_L(\omega) - f_R(\omega)]$$

$$\times \{\alpha_{LR} | t_{LR} |^2 + \operatorname{Im}[\alpha_{00}] \operatorname{Re}[G_{00}^r(\omega)]$$

$$+ \operatorname{Re}[\alpha_{00}] \operatorname{Im}[G_{00}^r(\omega)]\}, \qquad (3)$$

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where $\alpha_{LR} = 4\pi^2 \rho^2 / w^2$, $\alpha_{00} = -4\pi \rho z_L^- z_L^+ z_R^- z_R^{+*} / [w(|z_L|^2 + |z_R|^2)]$, $w = 1 + \pi^2 \rho^2 |t_{LR}|^2$, $z_L^{\pm} = t_{L0} \pm i\pi \rho t_{LR} t_{R0}^*$, and $z_R^{\pm} = t_{R0}^* \pm i\pi \rho t_{LR} t_{L0}^*$. The formula (3) includes two new terms: the first one corresponding to the current through the bridge channel and the second one proportional to $\operatorname{Re} G_{00}^r(\omega)$, which is responsible for the Fano resonance [5].

In order to determine the Green function G_{00}^r we choose, among a few known approaches [4], the equation of motion (EOM) method. Although the EOM describes the Kondo resonance only qualitatively, it takes into account all relevant interference processes and can be applied straightforwardly for our model (1) with the bridge channel. The method generates higher-order Green functions, which are truncated according to the self-consistent decoupling procedure proposed by Lacroix [13]. In the limit $U \rightarrow \infty$ the Green function at the dot is determined as

$$G_{00}^{r}(\omega) = \frac{1 - n/2 - a_{00}}{\omega - \epsilon_0 + i\Delta_0 - 2i\Delta_0 a_{00} - b_{00}},$$
 (4)

where $\Delta_0 = \pi \rho(|t_{L0}|^2 + |t_{R0}|^2)$, $a_{00} = [|z_L|^2 H_L(\omega) + |z_R|^2 H_R(\omega)]/w$ and $b_{00} = [|z_L|^2 F_L(\omega) + |z_R|^2 F_R(\omega)]/w$. Here, we use the functions

$$H_{\alpha}(\omega) = \frac{\rho}{w} \int_{-D}^{D} \frac{d\omega' f_{\alpha}(\omega') [G_{00}^{r}(\omega')]^{*}}{\omega - \omega'}, \quad (5)$$

$$F_{\alpha}(\omega) = \frac{\rho}{w} \int_{-D}^{D} \frac{d\omega' f_{\alpha}(\omega')}{\omega - \omega'}$$
$$= \frac{\rho}{w} \left\{ i\pi f_{\alpha}(\omega) + \ln \frac{2\pi k_{B}T}{D} + \operatorname{Re}\Psi \left[\frac{1}{2} - i\frac{\omega - \epsilon_{F\alpha}}{2\pi k_{B}T} \right] \right\}, \quad (6)$$

where Ψ is the digamma function and $\epsilon_{F\alpha}$ denotes the position of the Fermi level in the α electrode. Derivations were performed for the constant density of states $\rho(\epsilon) =$ 1/2D for $|\epsilon| < D$ (in our further calculations D is taken as unity). The Green function (4) is similar to that one obtained by Lacroix [13] if one exchanges the tunneling matrix $t_{\alpha 0}$ by an effective one z_{α}^{r} . The electron concentration at the dot is given by

$$n = -\frac{2}{\pi} \int d\omega f_0(\omega) \operatorname{Im}[G_{00}^r(\omega)], \qquad (7)$$

where $f_0(\omega) = \gamma_L f_L(\omega) + \gamma_R f_R(\omega)$ is the nonequilibrium distribution function at the dot, $\gamma_L = |z_L|^2/(|z_L|^2 + |z_R|^2)$ and $\gamma_R = |z_R|^2/(|z_L|^2 + |z_R|^2)$.

At T = 0 the functions $H_{\alpha}(\omega)$ and $F_{\alpha}(\omega)$ have logarithmic singularities at $\omega = \epsilon_{F\alpha}$, but $G_{00}(\omega)$ varies more smoothly around this point. At equilibrium Eq. (4) can be written as

$$G_{00}^{r}(\boldsymbol{\epsilon}_{F}) = \frac{[G_{00}^{r}(\boldsymbol{\epsilon}_{F})]^{*}}{2i\Delta_{0}[G_{00}^{r}(\boldsymbol{\epsilon}_{F})]^{*} + 1}.$$
(8)

A solution of this equation is $G_{00}^r(\epsilon_F) = [1 - e^{2i\phi}]/(2i\Delta_0)$, where the phase ϕ is taken according to the Friedel sum rule [4] as $\phi = \pi n/2$. On insertion of G_{00}^r

into (3) one can find the conductance (for the zero bias voltage $V \rightarrow 0$)

$$G = \frac{2e^2}{h} \left\{ \alpha_{LR} |t_{LR}|^2 - \frac{1}{2\Delta_0} \operatorname{Re}[\alpha_{00}(1 - e^{i\pi n})] \right\}.$$
 (9)

The electron concentration *n* can be associated with the relative position of the level $\Delta \epsilon = \epsilon_F - \epsilon_0$ as [4] $n = \frac{1}{2} + \frac{1}{\pi} \tan^{-1}[\Delta \epsilon / \Delta_0]$, which can be varied by the gate voltage applied to the dot.

For finite temperatures the set of the self-consistent equations (4), (5), and (7) is solved numerically. Figure 1a presents the results for the zero-bias conductance G through the system with the Kondo dot only $(t_{LR} = 0)$. The Kondo temperature is within the EOM [13] $T_K = 0.57 \exp(-\pi\Delta\epsilon/\Delta_0)/k_B\rho$ and the crossover from the mixed-valence to the Kondo regime is at $\Delta\epsilon_{cr} = \Delta_0/\pi - \Delta_0/\pi \ln(\rho\Delta_0/2\pi)$, which gives $\Delta\epsilon_{cr} \approx 0.056$ and max $(T_K) \approx 0.004$ for the parameters used in Fig. 1. At T = 0, G is a steplike function, whose maximum value $2e^2/h$ is reached in the Kondo regime (see also [14]).



FIG. 1. Conductance through the Kondo system with $t_{LR} = 0$ (a), $t_{LR} = -0.2$ (b), and $t_{LR} = 0.2$ (c) as a function of $\Delta \epsilon$ for T = 0, 2×10^{-6} , 2×10^{-4} , and 2×10^{-2} . For comparison G is shown for the dot without Coulomb interactions (U = 0) at a high temperature T = 0.02 (the dashed curves). In all our calculations $t_{L0} = 0.1$, $t_{R0} = 0.1$, for which $\Delta_0 = 0.031$.

At very high temperature $T \gg T_K$ Coulomb interactions are irrelevant, and the conductance peak is at $\Delta \epsilon = 0$ (see the curve corresponding to T = 0.02 in Fig. 1a). When $T < T_K$ the peak is shifted to the Kondo regime and increases logarithmically for $T \rightarrow 0$. Such a shift was observed in many experiments on quantum dots [15]. Since the EOM underestimates temperature dependences, one can expect more pronounced temperature changes for G than predicted by this method.

Figures 1b and 1c present the results for the system with the bridge channel. The conductance curves have an asymmetric shape, which is typical for a Fano resonance. The effect can be clearly visible for $|t_{LR}| \ge |t_{L0}|, |t_{R0}|$. If t_{LR} is negative (Fig. 1b), G exhibits a large maximum, whereas a deep minimum exists for positive values of t_{LR} (Fig. 1c). This results from constructive and destructive interference processes for electrons transmitted through two channels. Comparing G for the interacting and the noninteracting case (the solid and the dashed curves, respectively, in Fig. 1) one sees that correlations on the dot weaken the Fano resonance effect (the maximum and the minimum for the solid curves are smaller in the Kondo regime than those for the dashed curves).

In a similar way we calculated the source-drain voltage characteristics of the device. It was assumed that the potential V is applied to the left electrode and in the right electrode the potential is kept zero. Figure 2 presents the evolution of the differential conductance dI/dV with the variation of the relative position of the impurity level $\Delta \epsilon$, from the Kondo to the mixed-valence regime. The case for the pure Kondo dot $(t_{LR} = 0)$ is given in Fig. 2a. If the impurity level lies in the Kondo regime, the curves show a very narrow peak at low voltage due to the Anderson hybridization. The sharp feature in the mixed-valence regime (the dash-dotted curve in Fig. 2a) we attribute to the EOM method. The peak disappears when $\Delta \epsilon$ approaches the empty state regime (see the dotted curve). Out of equilibrium the Kondo peak is split into two peaks, which are pinned to $\epsilon_F + eV$ and ϵ_F (i.e., to the chemical potentials of the left and the right electrode, respectively). This is manifested in the narrow peak of dI/dV, which was observed experimentally as well [15]. The broad maximum seen in Fig. 2a results from the resonant tunneling when the chemical potential $\epsilon_F + eV$ approaches ϵ_0 .

The influence of the bridge channel is presented in Figs. 2b and 2c. A direct electron transmission increases the differential conductance (for our case the bridge channel contribution to G is $0.33 \times 2e^2/h$). The dI/dV curves in Fig. 2b are similar to those in Fig. 2a. Although the broad resonance maxima are deformed, there are well pronounced narrow peaks in the low voltage regime. The situation for $t_{LR} = 0.2$, presented in Fig. 2c, is, however, different. In the low voltage range the curves show a narrow dip instead of a peak. In this case there is a destructive interference of electronic waves passing through the bridge and the Kondo dot. If a small voltage is applied the transmission through the Kondo dot is lowered, which weakens



FIG. 2. Differential conductance as a function of the applied voltage for $\Delta \epsilon = 0.15$ (solid curve), 0.1 (dashed curve), 0.05 (dash-dotted curve), and 0 (dotted curve) at $T = 2 \times 10^{-4}$.

interference of the two channels. It results in the opening of the bridge channel and increase of the conductance. We found that temperature and voltage characteristics for the dip are similar to those for the low voltage peak in the Kondo dot. It is not surprising as the Kondo resonance plays a crucial role in both the situations.

Recent experiments performed by Göres *et al.* [1] showed that the gray-scale plot of dI/dV in the plane of the gate voltage and the source-drain voltage has a diamond-shaped structure. The behavior is familiar to that one found in the Kondo dot; however, it is a negative picture with dips in place of peaks. As we explained above, the picture results from weakening of destructive interference processes in the system and opening the bridge channel.

Let us now analyze electron transport though the Aharonov-Bohm ring with the Kondo dot. In this case the hopping integrals are complex numbers $t_{\nu} = |t_{\nu}|e^{i\phi_{\nu}}$ ($\nu = LR, L0, R0$), where ϕ_{ν} corresponds to the phase of the electronic wave passing through the ν arm of the ring in the presence of the magnetic field. At T = 0 the conductance is given by Eq. (9), which simplifies the Kondo regime (n = 1) to the form

$$G = \frac{2e^2}{h} \frac{4|t_{L0}|^2|t_{R0}|^2}{(|t_{L0}|^2 + |t_{R0}|^2)^2 w^2} \times [1 + \pi^4 \rho^4 |t_{LR}|^4 - 2\pi^2 \rho^2 |t_{LR}|^2 \cos(2\pi \Phi/\Phi_0)].$$
(10)

Here, $\Phi = (\phi_{LR} - \phi_{L0} - \phi_{R0})/2\pi\Phi_0$ is the magnetic flux enclosed in the ring and $\Phi_0 = hc/e$ denotes the one-electron flux quantum. For T > 0 the electronic transport is calculated numerically and the results are presented in Fig. 3. The conductance shows oscillations with Φ (Fig. 3a) with a large amplitude in the mixed-valence regime. In the Kondo regime the amplitude is smaller, but strongly temperature dependent. Figure 3b presents evolution of the voltage dependence of dI/dV with the magnetic flux Φ . At $\Phi = 0$ there is a dip in the curve, which is continuously transformed to a peak for $\Phi = 0.5hc/e$.

Just recently van der Wiel *et al.* [9] have performed an experiment on electron transport through the Aharonov-Bohm ring made in two-dimensional electron gas with a quantum dot in one of the arms. The zero-bias conductance, in their experiment, increases considerably and



FIG. 3. Characteristics of the Aharonov-Bohm ring with the Kondo dot: (a) the zero-bias conductance vs the magnetic flux for $\Delta \epsilon = 0.1, 0.05, 0$ at $T = 2 \times 10^{-6}$ (solid curves) and T = 0 (dashed curves); (b) the differential conductance vs the source-drain voltage for $\Phi = 0.5hc/e$ (solid curves), 0.25hc/e (dashed curves), 0.125hc/e (dash-dotted curves), and 0 (dotted curves) at $T = 2 \times 10^{-6}, \Delta \epsilon = 0.05$.

can reach even the value of $2e^2/h$ in some magnetic field ranges. It is in agreement with our results in Fig. 3a, where G can increase to $2e^2/h$ for the Kondo dot if $T \rightarrow 0$ (see also [8]). We expect that this type of experiment [7,9] should also show transformation from a peak to a dip in the voltage dependence of dI/dV as a function of flux through the ring (as seen in Fig. 3b).

Summarizing, our theoretical studies of the electronic transport through the quantum dot of the Kondo type showed that the interference of traveling waves with the localized state can lead to the Fano effect, for which the current characteristics are strongly modified in the Kondo regime. The source-drain voltage dependence of the conductance exhibits a large peak or a dip, depending on the interference conditions. We predict that interference effects should be pronouncedly seen in transport through the Aharonov-Bohm ring with the Kondo dot.

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Note added.—After submission of this Letter we learned of work by Heemeyer [16], in which qualitatively similar results were obtained for the zero-bias conductance (as in Fig. 1) within the mean-field slave-boson approach for the model with the bridge channel.

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